



RITdb

Data Infrastructure for Backend Smart Manufacturing

RITdb Task Force

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CONNECT - COLLABORATE - INNOVATE - GROW - PROSPER

Main Pillars of Industry 4.0

HIR
Traceability

Augmented Reality

MQTT/CBOR

Cloud
Computing

Smart Test Cell ++

Cyber
Security

Systems
Integration

Replay
Engine

Data

Autonomous
Robots

Artificial
Intelligence

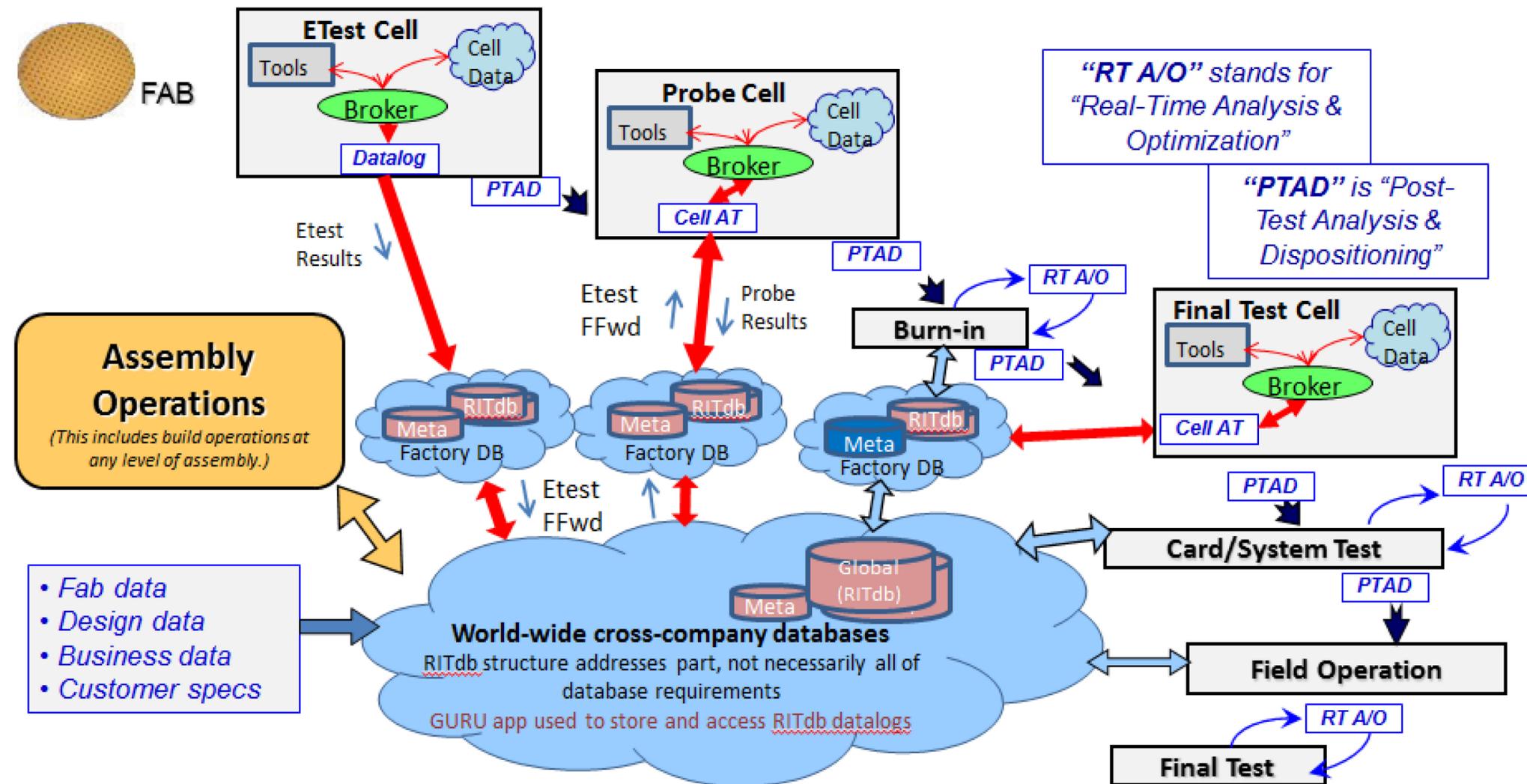
ETL - provisioning
data that is ready to
use!

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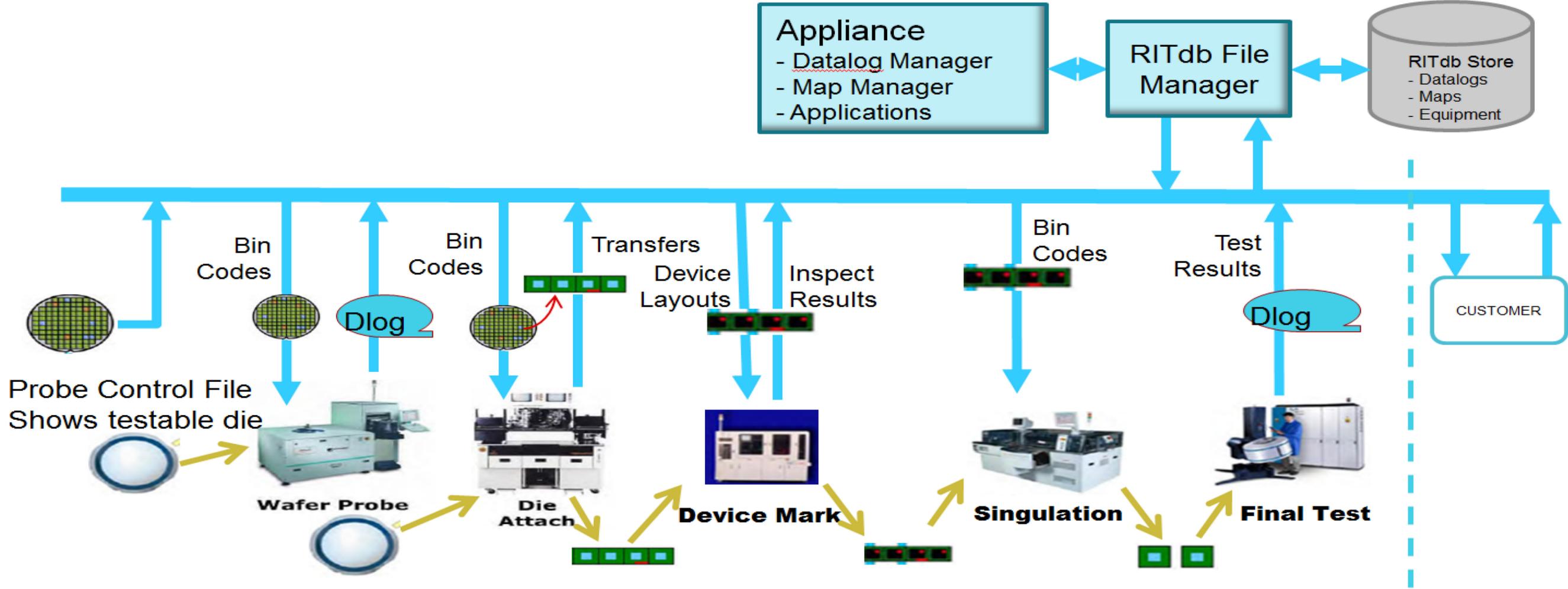
Expectation of Smart Mfg for Backend

- Faster response time
- Improved Quality
- Improved Utilization
- Democratization of the data
 - Test Floor is a data lake...
 - Easy insertion/easy use
 - More data sources for more precision decision
 - Better Monitoring
- Traceability
- Integration of Legacy Equipment

Big Data Universe

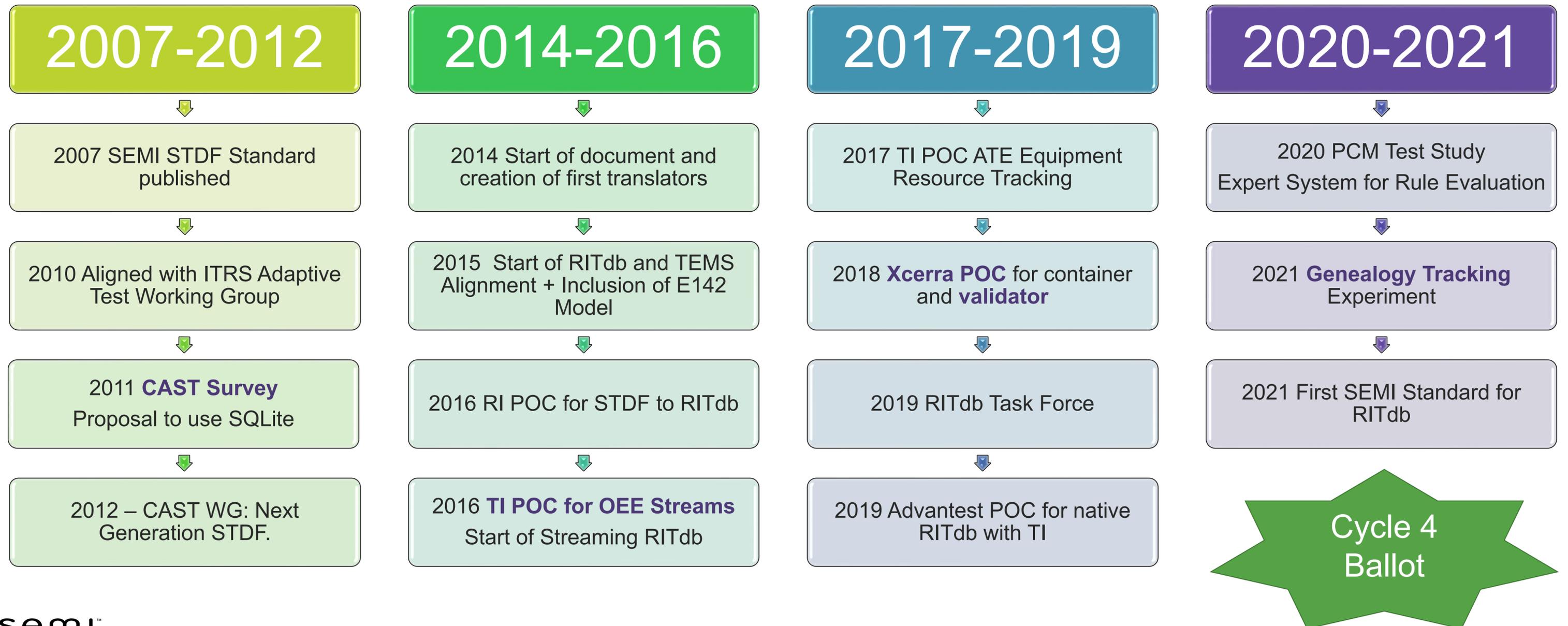


Backend Data flow



timeline

How did we arrive at RITdb



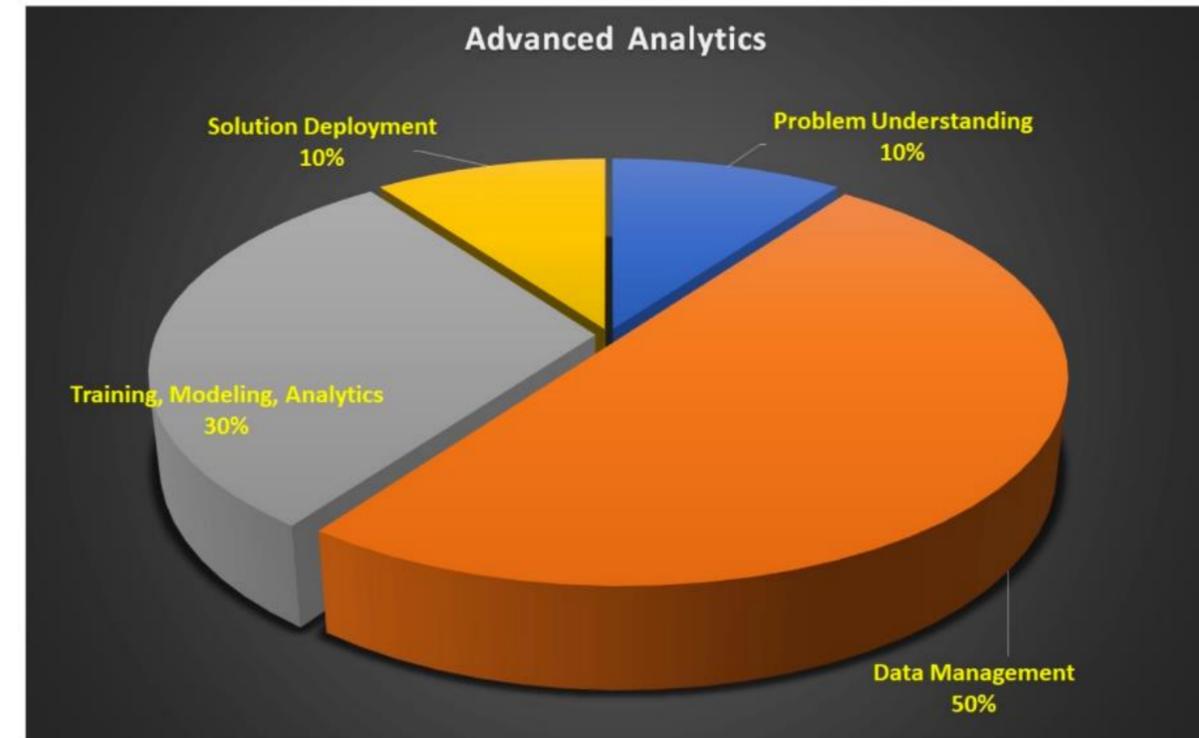
CAST Member Survey (2011)

1. Data

- ETL necessary for the wide variety of data in the back end. 60+%
- First focus is on data availability.
- Shared data model will reduce the ETL issue

2. Adaptive Test

- Issue is the scope of the cells and variation of flow.
- Wide variability of algos, accessing the data, & response time.



Opportunity identified was for data management.

#1 Priority

RITdb Container

- SQLite
- Can be queried using SQL
- No SQL narrow table
- Can be machine validated against spec.
- Attached metadata for provenance
- Validated with many STDF examples

RITdb Data Container: datalog example

```

----- Parametric Test Result Record -----
Ptr.rec_len      = 65  MSB = 0x00,  LSB = 0x00
Ptr.rec_typ     = 15
Ptr.rec_sub     = 10
Ptr.test_num    = 100001  MSB = 0x00,  0x01,  LSB = 0x00
Ptr.head_num    = 1
Ptr.site_num   = 255
Ptr.test_flg   = 0x12
Ptr.parm_flg   = 0xd0
Ptr.result     =
Ptr.test_txt   =
Ptr.alarm_id   =
Ptr.opt_flag   = 0x00
Ptr.res_scal   = 0
Ptr.llm_scal   = 0
Ptr.hlm_scal   = 0
Ptr.lo_limit   = -0.7942
Ptr.hi_limit   = -0.3058
Ptr.units     = VOLTS
Ptr.c_resfmt   = %9.4f
Ptr.c_llmfmt   = %9.4f
Ptr.c_hlmfmt   = %9.4f
Ptr.lo_spec   = NaN  not present
Ptr.hi_spec   = NaN  not present
    
```

PTR => test_info

PTR => limits

```

----- Part Information Record -----
Pir.rec_len     = 2  MSB = 0x00,  LSB = 0x02
Pir.rec_typ    = 5
Pir.rec_sub    = 10
Pir.head_num   = 1
Pir.site_num   = 1
    
```

PIR/PRR = test event

```

----- Parametric Test Result Record -----
Ptr.rec_len     = 19  MSB = 0x00,  LSB = 0x00
Ptr.rec_typ    = 5
Ptr.rec_sub    = 20
Ptr.head_num   = 1
Ptr.site_num   = 1
Ptr.parm_flg   = 0x08
Ptr.test_flg   = 0x00
Ptr.test_txt   =
Ptr.alarm_id   =
Ptr.opt_flag   = 0x00
Ptr.res_scal   = 0
Ptr.llm_scal   = 0
Ptr.hlm_scal   = 0
Ptr.lo_limit   = NaN  not present
Ptr.hi_limit   = NaN  not present
Ptr.units     =
Ptr.c_resfmt   =
Ptr.c_llmfmt   =
Ptr.c_hlmfmt   =
Ptr.lo_spec   = NaN  not present
Ptr.hi_spec   = NaN  not present
    
```

Ptr.result, *flg

```

----- Parametric Test Result Record -----
Ptr.rec_len     = 18  MSB = 0x00,  LSB = 0x00
Ptr.rec_typ    = 15
Ptr.rec_sub    = 10
Ptr.test_num    = 100001  MSB = 0x00,  0x01,  LSB = 0x00
Ptr.head_num    = 1
Ptr.site_num   = 1
Ptr.test_flg   = 0x80
Ptr.parm_flg   = 0xd0
Ptr.result     = -10.25
Ptr.test_txt   = not valid
Ptr.alarm_id   = FAIL
Ptr.opt_flag   = 0xff  not present
Ptr.res_scal   = 0  not present  not valid
Ptr.llm_scal   = 0  not present  not valid
Ptr.hlm_scal   = 0  not present  not valid
Ptr.lo_limit   = NaN  not present  not valid
Ptr.hi_limit   = NaN  not present  not valid
Ptr.units     =
Ptr.c_resfmt   =
Ptr.c_llmfmt   =
Ptr.c_hlmfmt   =
Ptr.lo_spec   = NaN  not present  not valid
    
```

sequence	entityID	indexID	name	value	value2
1344355240000035	2	4	ACTIVE_SITE	4	



Provenance

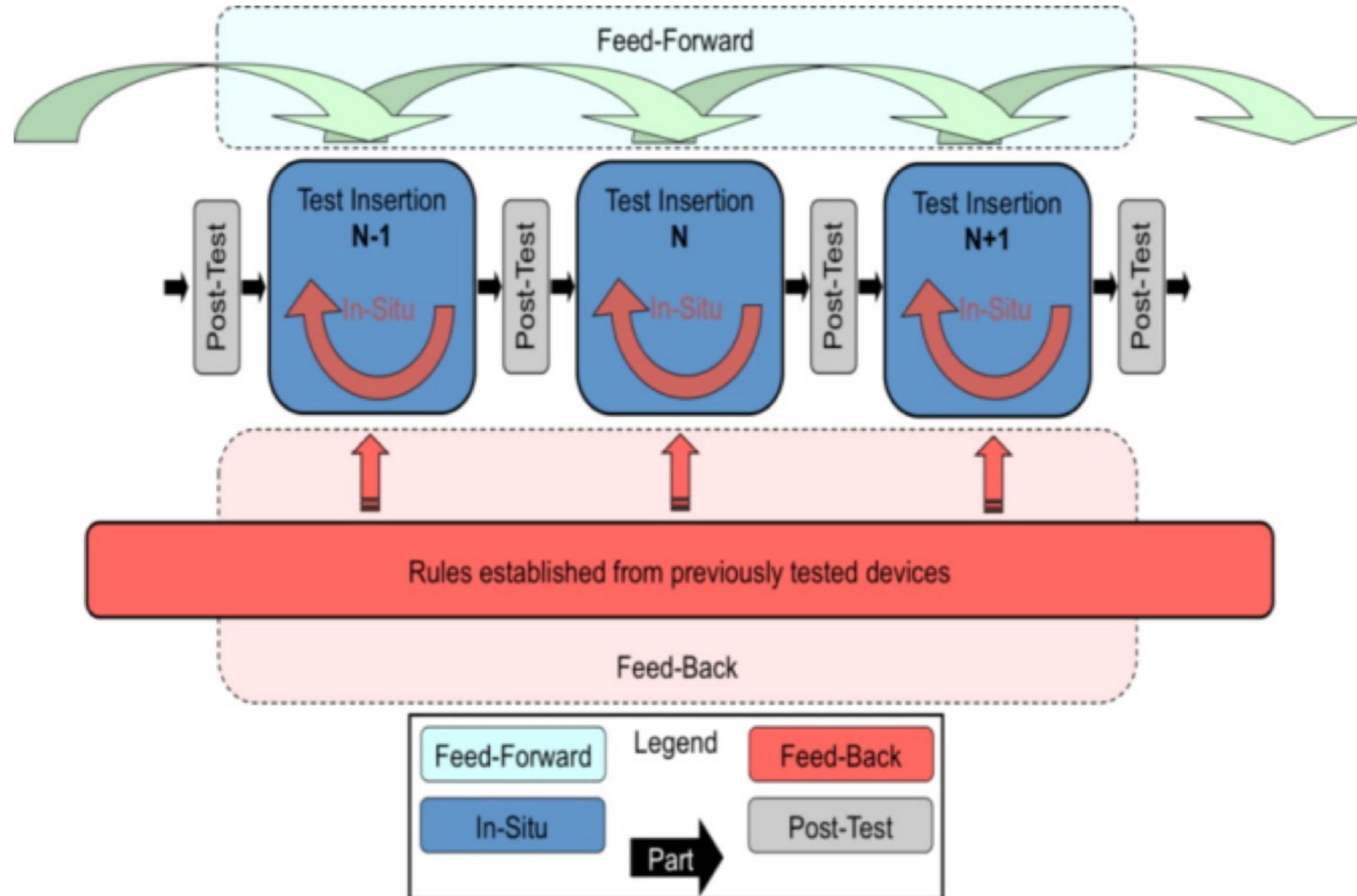
- Source Identity
 - Who created the data
- Integrity
 - Is it the data they created
- Security
 - Who can access the data
- Classification
 - Grouping by some characteristic
 - Source, content, type, product,time,.....
- Lineage
 - Where it has been and what happened to it

Evaluation of Other Data Types

- Validated in POC
 - Probe
 - Final Test (Singulated/Strip)
 - Equipmentlog (ATE – 10+)
 - Traceability
 - OEE Events
- Designed – to be tested
 - E142 (HIR)
 - PCM (WAT, inline electrical)
 - SLT
 - Equipmentlog (other)
 - Large digital Test Data
 - AI/ML structures

#2 priority

Adaptive Test



Streaming RITdb is a flexible, extendable system with the ability to collect and act upon data in real-time.

Real Time data system modeled on M2M IOT enabling Plug and Play for tools and test support applications. Data is bi-directional.

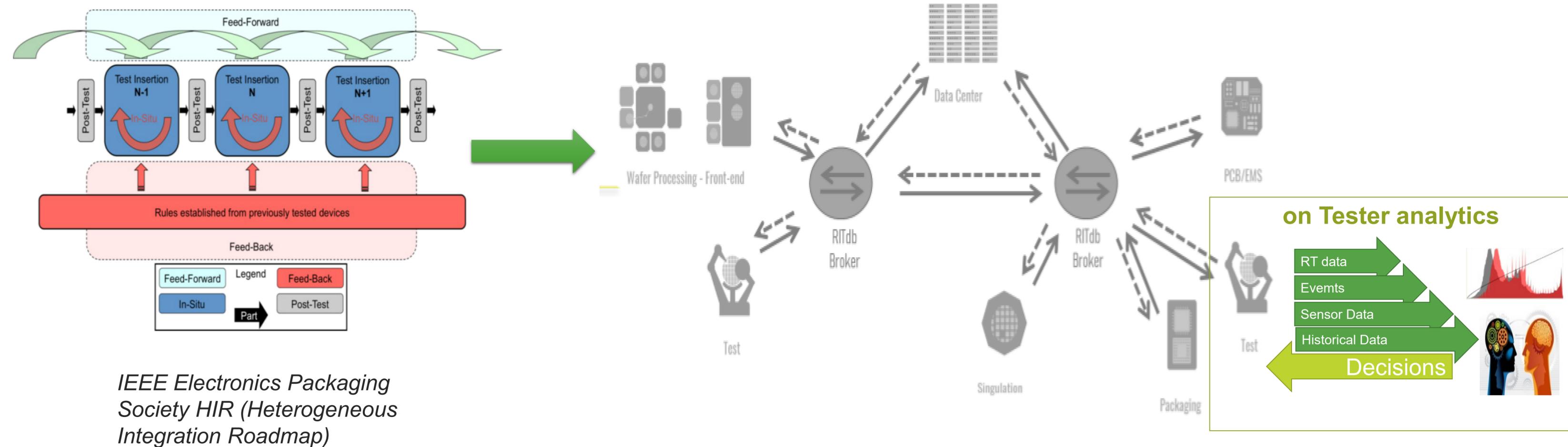
Standard addresses data streaming, transport and storage. i.e. supports generation and access to real-time streaming data as well as batch data (history)

Allows for data from different producers to be merged and synchronized, and then delivered to consumer. Can be run in parallel with existing systems.

Supports data security and integrity as well as allowing addition of new types of data without impacting existing model

Data is distributed, integrates with Adaptive Test Model and Big Data

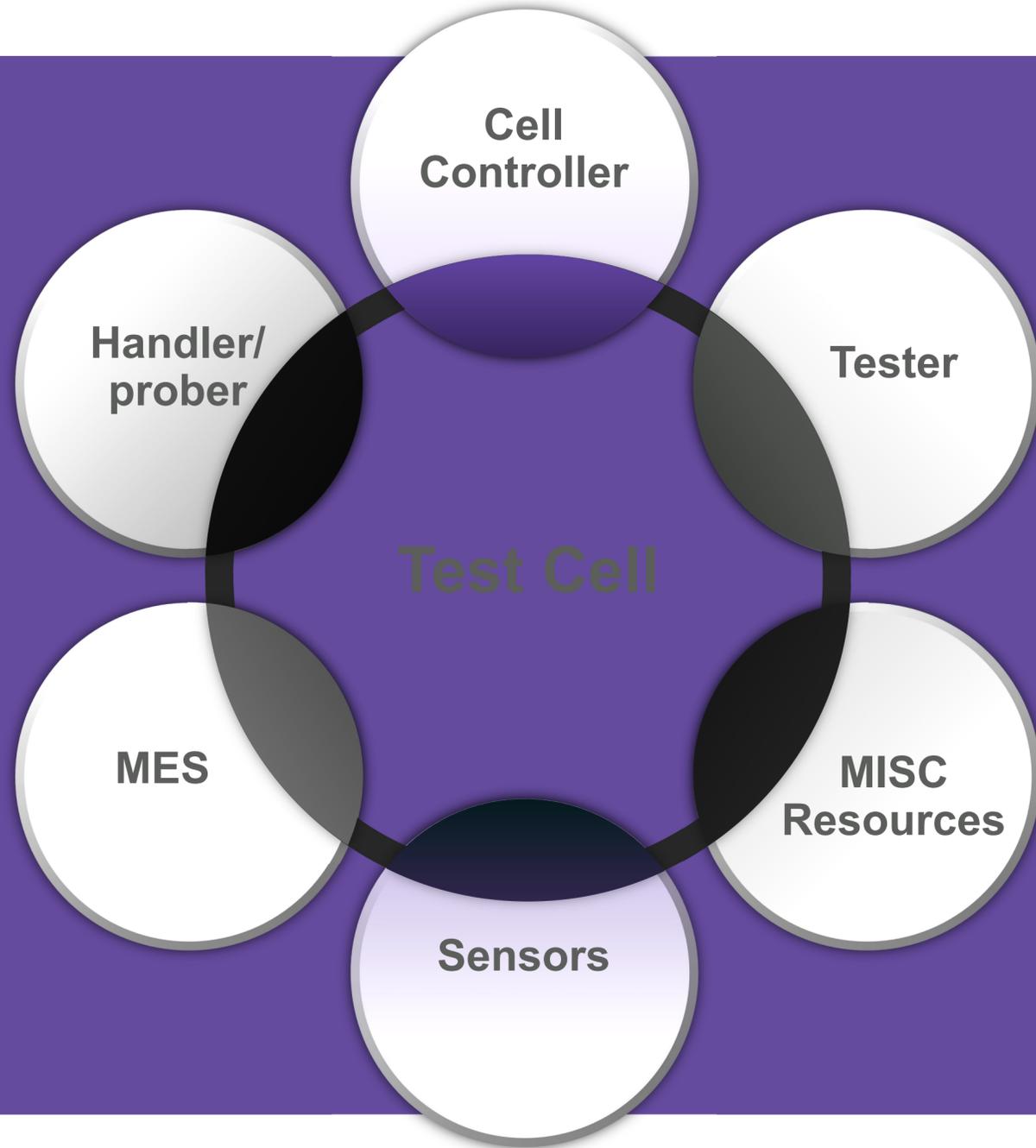
Industrial Internet of Things enables Adaptive Test



Events come from many sources:

ATE, OEE, Handler/Prober, Test Cell Control
 MES, Automation Systems,

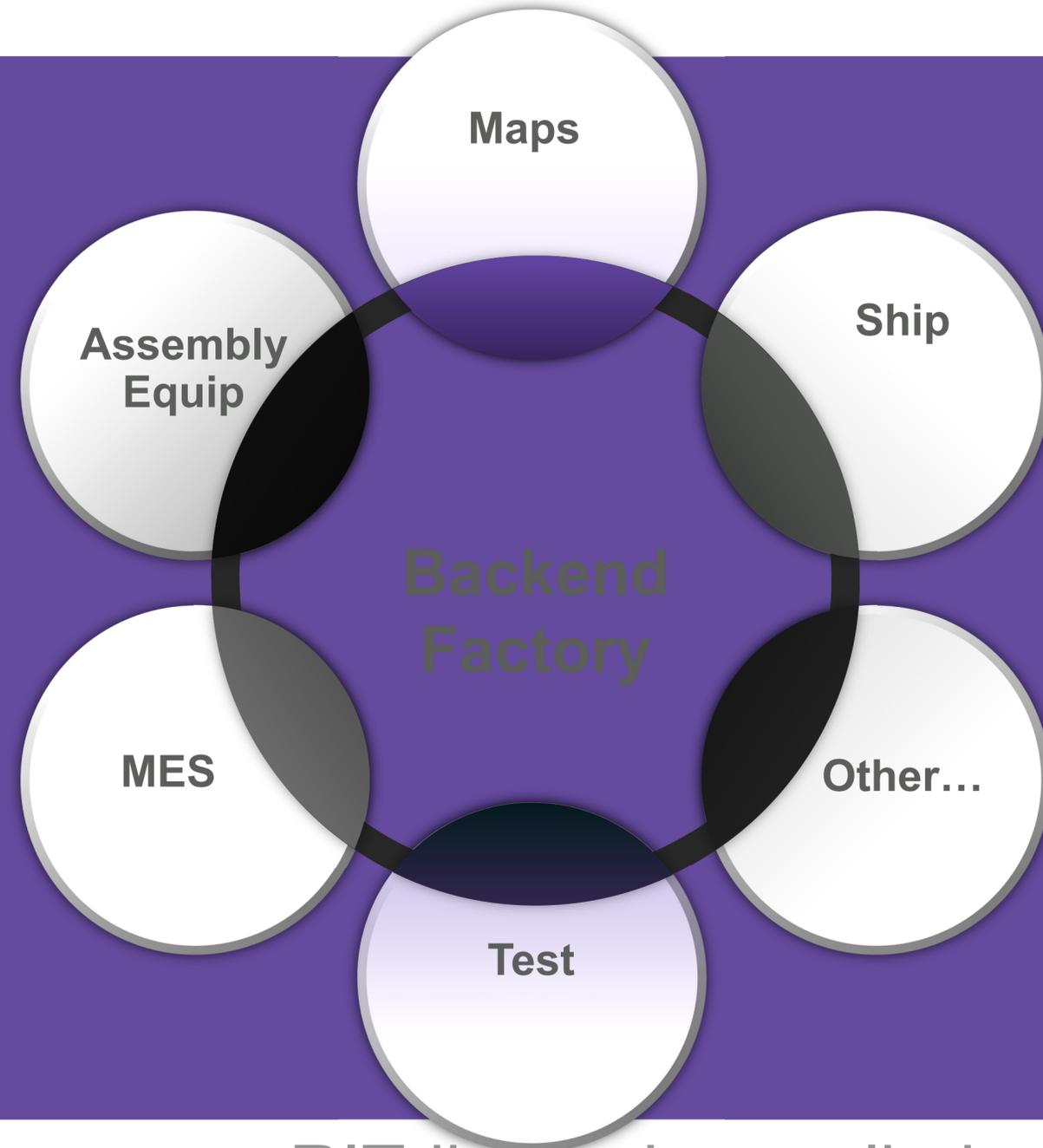
RITdb Opportunities:



Add ability to stream information from all parts of a test cell.

- Cell controller – record key information/decisions from cell control.
- Handler/Prober – monitor critical settings, recipe setup,...
- Tester – Monitor tester diagnostics/calibration and integrate with operations when potential issue is identified.
- Sensors – Integrate sensor events with test events.
- *And much more....*

RITdb Beyond the Test Cell:



Add ability to stream information from anywhere

- Record Maps and product transformations. i.e. wafer die to Strip location, Strip to Tape & Reel, die to multi-product packages,.....
- Generate events across backend flow. Allow better alignment between probe, assembly and test.

*** Backend: from PCM to Ship

RITdb can be applied across the eco system not just the test cell.

RITdb – A foundation for Smart Manufacturing Backend Data

- RITdb Features

- RITdb Containers and/or streams of data
- Capable of integrating batch data with individual streams

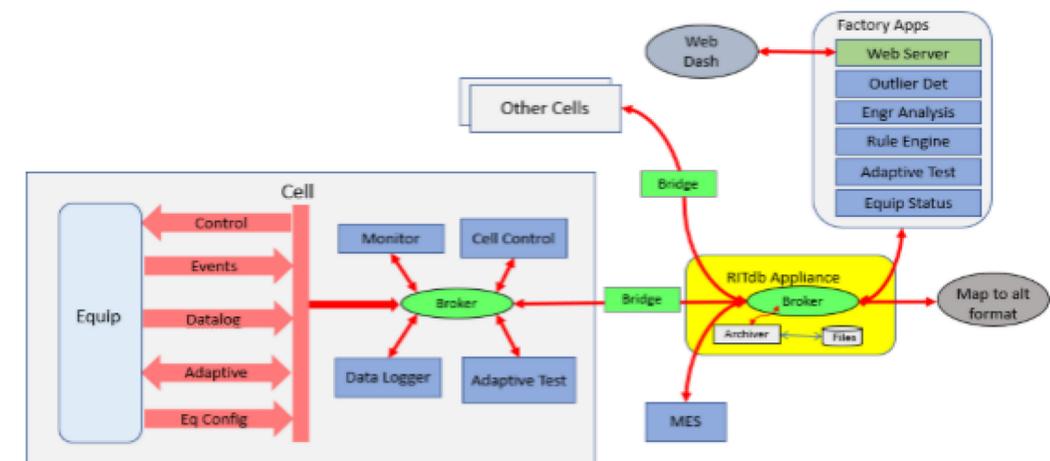
- RITdb bi-directional messaging

- Exchange information between Test cell and anything else connected to RITdb (data or control)
- Enables operational control and data analytics

Build upon IoT architecture using MQTT messaging protocol

- Modern open source message based communication enables plug and play tools and applications
- Adds layer of security with private/public key sharing rules
- Easily integrates into Big Data infrastructure

Logical Model for a Test Cell RITdb Environment



Red lines - MQTT channels which carry RITdb messages
Dark blue - examples of cell and factory functionality
Brown - legacy tool support

POC - Applications

POC (completed/active)

- RITdb Tools
- ATE Equipment Resource Tracking
- Data Visualization
- Replay engine
- Rules Engine
- Traceability
- ATE Clients (JAVA, C++, Python)

POC (Planned)

- SLT
- Bench Testing
- Cell Topology
- Data Analysis Scaling
- Failure Recovery/Updates
- Security/Encryption
- Big Digital
- AI/ML
- Robot Integration
- Cloud Integration

Next Steps for RITdb Standard

- **RITdb Ballot - Cycle 4**

- Voting Period Starts: Wednesday, April 28, 2021
- Voting Period Ends: Friday, May 28, 2021

- Event Message Standardization

- Machine Learning Support

Where should we go next?